CHANGE NOTIFICATION



January 13, 2014

Dear Sir/Madam:

PCN# 011314

Subject: Notification of Assembly Process Change for LTM8042/LTM8042-1

Please be advised that Linear Technology Corporation has made a minor change to the internal package construction to facilitate the use of one attach material for both die and components. The die attach material is changed from epoxy to solder, which is already used for attaching components in the same μ Module device package. In order to use the solder die attach, the die attach paddle (DAP) has been modified by splitting the DAP into multiple pads for dice D1 and U1. Additionally, the attach pad for component C1 has also been split into multiple pads. Linear has been shipping several μ Module devices using solder for die attach and component attach.

Besides these changes, no functional, parametric, mechanical, or datasheet specifications are affected and the component bill of materials remains unchanged. Similarly, there are no changes associated with the package footprint, PCB layout or product top marking, so the customer applications will be unaffected.

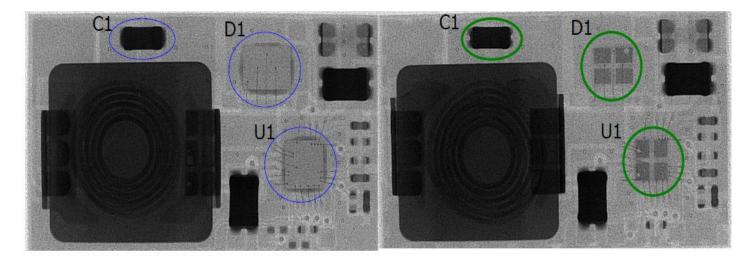
Parts incorporating the new substrate design have been fully characterized and tested for package level reliability. The change was qualified by performing extensive characterization over the full operating voltage and temperature ranges and MSL3 preconditioning. Devices from the same μ Module device product families have been subjected to 1000 cycles of temperature cycles and thermal shock. Products built using the improved design are targeted for shipment after March 14, 2014.

Should you have any further questions, please feel free to contact me at 408-432-1900 ext. 2077, or by E-mail <u>JASON.HU@LINEAR.COM</u>. If I do not hear from you by March 14, 2014, we will consider this change approved by your company.

Sincerely,

Jason Hu Quality Assurance Engineer

LTM8042/-1 - Current and New Design



BEFORE: EPOXY + STD DAP

AFTER CHANGE: SOLDER + WP DAP



					TECHNOLOGY				
	P		IABILITY DAT	•					
LTM80xx Solder Die Attach Qualification Report									
1/7/2014									
1/7/2014									
OPERATING LIFE	EIESI								
DEVICE	SAMPLE	OLDEST	NEWEST	K DEVICE	NUMBER				
TYPE	SIZE	DATE CODE	DATE CODE	HOURS	OF FAILURES				
				AT +150°C	TAILONES				
LTM8008	77	1210	1210	77.00	0				
LINOUUU	77	1210	1210	77.00	0				
		G: 192h +30°C/60%	R H SOAK 3x REE						
J-STD-020 MSL 3 PRECONDITIONING: 192h +30°C/60%R.H. SOAK, 3x REFLOW AT +245°C PEAK									
DEVICE	SAMPLE	OLDEST	NEWEST		NUMBER				
TYPE	SIZE	DATE CODE	DATE CODE		FAILURES				
LTM8001	199	1236	1236		0				
LTM8008	462	1210	1210		0				
LTM8021	204	1306	1306		0				
LTM8023	204	1245	1245		0				
LTM8025	204	1245	1245		0				
LTM8027	77	1320	1320		0				
LTM8028	184	1236	1236		0				
LTM8029	246	1239	1239		0				
LTM8032	204	1302	1302		0				
LTM8033	204	1306	1306		0				
LTM8042	230	1339	1339		0				
LTM8045	152	1225	1225		0				
LTM8047	77	1242	1242		0				
LTM8048	274	1232	1236		0				
LTM8052	358	1239	1239		0				
LTM8058	204	1239	1239		0				
LTM8061	204	1309	1309		0				
LTM8062	231	1330	1330		0				
	3,918				0				
HIGH TEMPERAT	URE BAKE at 150°	C							
DEVICE	SAMPLE	OLDEST	NEWEST	K DEVICE	NUMBER				
TYPE	SIZE	DATE CODE	DATE CODE	HOURS	OF FAILURES				
				AT +150°C	TAILOINES				
LTM8001	25	1236	1236	25.00	0				
LTM8008	77	1210	1210	77.00	Ö				
LTM8021	50	1306	1306	50.00	õ				
LTM8023	50	1245	1245	50.00	Ő				
LTM8025	50	1245	1245	50.00	ŏ				
LTM8029	50	1239	1239	50.00	0				
LTM8032	74	1302	1302	74.00	ō				
LTM8033	77	1306	1306	77.00	0				
LTM8042	77	1339	1339	38.50	Ō				
LTM8045	50	1225	1225	50.00	0				
LTM8052	50	1239	1239	50.00	0				
LTM8058	50	1239	1239	50.00	0				
LTM8062	77	1330	1330	77.00	0				
	757			718.50	0				
• HIGHLY ACCELERATED STRESS TEST (+130°C/85%R.H. w BIAS)									
DEVICE	SAMPLE	OLDEST	NEWERT	K DEVICE	NUMBER				
TYPE	SAMPLE SIZE	OLDEST DATE CODE	DATE CODE	HOURS	OF FAILURES				
		Diffe CODE		AT +85°C	FAILURES				
1 TM9009	46	1210	1210	00.00	0				
LTM8008	46 46	1210	1210	88.32	0 0				
		STRESS TEST (14)	30°C/85% P H \ (1)	88.32	U				
- UNDIASED HIGH	AUGELERATED	SINE33 1231 (+1)	00 0/00%R.H.) **						
DEVICE	SAMPLE	OLDEST	NEWEST	K DEVICE	NUMBER				
TYPE	SIZE	DATE CODE	DATE CODE	HOURS AT +131°C	OF FAILURES				
LTM8001	43	1236	1236	4.13	0				
LTM8023	50	1245	1245	4.80	õ				
LTM8025	50	1245	1245	4.80	õ				
LTM8028	30	1236	1236	2.88	Ő				
LTM8029	70	1239	1239	6.72	õ				
LTM8032	50	1302	1302	4.80	õ				
LTM8033	50	1306	1306	4.80	õ				
LTM8045	49	1225	1225	8.23	õ				
LTM8052	50	1239	1239	4.80	õ				
LTM8058	50	1239	1239	4.80	õ				
LTM8061	50	1309	1309	4.80	Ő				
LTM8062	77	1330	1330	3.70	ō				
	665			61.46	0				
J	•			· · · · · · · · · · · · · · · · · · ·					

Confidential Statement This change notice is for Linear Technology's Customers only. Distribution or notification to third parties is prohibited.



	В				TECHNOLOGY				
PACKAGE RELIABILITY DATA LTM80xx Solder Die Attach Qualification Report									
1/7/2014									
• TEMPERATURE/HUMIDITY STORAGE (+85°C/85%R.H.) ⁽¹⁾									
DEVICE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE HOURS AT +85°C	NUMBER OF FAILURES				
LTM8008 LTM8062	77 50 77	1210 1330	1210 1330	77.00 25.00 77.00	0 0 0				
• TEMP CYCLE FROM -65°C to +150°C ⁽¹⁾									
DEVICE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE CYCLES	NUMBER OF FAILURES				
LTM8008 LTM8032 LTM8033 LTM8052 LTM8061	231 77 77 77 77 539	1210 1302 1306 1239 1309	1210 1302 1306 1239 1309	231.00 77.00 77.00 77.00 77.00 77.00 539.00	0 0 0 0 0 0				
• TEMP CYCLE FROM -55°C to +125°C ⁽¹⁾									
DEVICE TYPE	SAMPLE SIZE	OLDEST DATE CODE	DATE CODE	K DEVICE CYCLES	NUMBER OF FAILURES				
LTM8001 LTM8021 LTM8023 LTM8023 LTM8025 LTM8027 LTM8028 LTM8029 LTM8047 LTM8047 LTM8048 LTM8048 LTM8052 LTM8052 LTM8058 LTM8058 LTM8052	77 77 77 77 77 77 77 77 102 77 77 1,026 K FROM -65°C to +	1236 1306 1245 1245 1320 1236 1239 1225 1242 1232 1239 1239 1330	1236 1306 1245 1245 1320 1236 1239 1225 1242 1236 1239 1239 1239 1330	77.00 77.00 77.00 77.00 77.00 77.00 77.00 77.00 140.50 77.00 77.00 77.00 38.50 1,026.00	0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0				
DEVICE			LIEUEOT		NUMBER				
TYPE	SAMPLE SIZE	OLDEST DATE CODE	DATE CODE	CYCLES	OF FAILURES				
LTM8008 LTM8032 LTM8033 LTM8052 LTM8061	231 77 77 77 77 539	1210 1302 1306 1239 1309	1210 1302 1306 1239 1309	231.00 77.00 77.00 77.00 77.00 77.00 539.00	0 0 0 0 0				
THERMAL SHOC	K FROM -55°C to +	125°C ⁽¹⁾							
DEVICE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE CYCLES	NUMBER OF FAILURES				
LTM8001 LTM8021 LTM8023 LTM8025 LTM8025 LTM8028 LTM8049 LTM8045 LTM8048 LTM8052 LTM8058 LTM8052	77 77 77 77 77 75 126 77 77 77 894	1236 1306 1245 1245 1236 1239 1225 1232 1239 1239 1239 1330	1236 1306 1245 1245 1236 1239 1225 1236 1239 1239 1239 1330	77.00 77.00 77.00 77.00 77.00 75.00 126.00 77.00 77.00 77.00 894.00	0 0 0 0 0 0 0 0 0 0 0 0 0 0 0				
					NUMBER				
DEVICE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE CYCLES	OF FAILURES				
LTM8008	15 15	1210	1210	22.50 22.50	0 0				
(1) Environmental stress are preceded by JEDEC Level 3 Preconditioning: 192h 30°C/60% R.H. soak, followed by 3x Reflow at 245°C									

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